

IAP4 PCT/PTO 23 NOV 2005
PCT

Docket No.: 4752-005

PATENT



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of :
Inventor(s): Naofumi AOKI et al. : Confirmation No. 1411
U.S. Patent Application No. 10/531,584 :
Filed: April 18, 2005 :

For: UNAUTHORIZED-ALTERATION DETECTING METHOD, UNAUTHORIZED-
ALTERATION DETECTING PROGRAM, AND RECORDING MEDIUM HAVING
RECORDED THE PROGRAM

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

This is further to the Information Disclosure Statement as filed on April 18, 2005. In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

Respectfully submitted,

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**INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION****(PTO-1449)**ATTY. DOCKET NO.
4752-005U.S. PATENT
APPLICATION NO.
10/531,584APPLICANT
Naofumi AOKI et al.FILING DATE
April 18, 2005

GROUP

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	Paten Abstact of Japan 2002-201703 July 19, 2002
EXAMINER	DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.